Finding the thermal distribution of wake losses

Using time domain simulation, combined domain analysis, and thermal simulation, to predict the heating of diagnostic components

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Why are we worried?

- Diagnostics systems are *designed* to couple to the beam.
- Wake loss factor is large enough to give uncomfortably large amounts of energy being lost from the beam.
- We plan to go to higher currents and shorter bunches.
- Current settings imply 189W lost in striplines
- Planned settings imply 313W lost in striplines

What next?

- **EM simulation** ->Where does the energy go?
- O Dissipated into the structure?
- Transmitted down the beam pipe?
- o Transmitted out of measurement ports?

Thermal simulation ->Does it cause a heating problem?



One structure... many simulations

As a minimum

- Full lossy (finite conductivity, complex permittivity)
- No losses (PEC, real permittivity)

Then

• Lossy with the component of interest made lossless.

The EM models

2 stipulations

- The mesh must be fine enough to have stable results (absolute)
- The simulation must have run long enough for the majority of energy to have left the structure (somewhat flexible)

From EM simulation get:

Wake loss factor, Wake impedance Wake potential Port/mode signals Bunch charge distribution Energy in structure

Result	Time domain	Frequency domain		Check	Time domain	Frequency domain
Wake loss factor				Does the energy decay?Total port power < energy lost from beamSum of port spectra < bunch loss spectra at all frequencies.		
Wake impedance						
Energy lost from beam						
Energy out of measurement ports						
Energy out of beam pipe						
Port spectra						
Beam loss spectra						

~14hrs per simulation

Example: Striplines





Example:Striplines



1nC 16ps bunch



Example:Striplines



7 hrs lossy/component 46hrs lossless

Example: BPM





Example:BPM



1nC 10ps bunch





Extensions

We have the wake impedance which is the response of the structure **only**. We can now multiply it with different spectra...

- multiple bunches
- Different bunch lengths
- Machine parameter studies

Have to use reconstructed wake impedance as it has better fidelity.



Are the extensions valid?

We can only check single bunch variation ... however the multi bunch extension uses the same technique just with different beam spectra.



Structure is simplified stripline







Thermal simulation 300mA





Thermal simulation 500mA





Comparison with real world data













Thermal simulation 500mA Coax pin 77°C Block 44°C Ceramic 77°C Anulus 4 62°C Button 87°C

Kloss = 858 mV/pC Bunch length 5mm Simulation time = 1h x4 16core 3.1GHz CPU 64GB ram, 128GB SSD





Improvements to be done

- Combining all extensions
- Signal extensions allows shorter simulations

• 3D thermal simulation

- More comparisons with real world data.
- Thermal
- Output signals

Final thoughts

 For all the structures tested so far, a large fraction of the power is sent down the beam pipe. This will act as an additional heat load on nearby structures. Does this mean we should model adjacent models together?

Additional details

Spectral overlap

Stripline

BPM





Primary BPM



Analysis details – Time domain

normalised charge = $\frac{\text{Charge distribution data}}{\text{model charge}}$

wake loss distribution = normalised charge * Wake Potential

wake loss factor = $-\sum_{\text{time}}$ wake loss distribution * time step size

loss from bunch = wake loss factor * model charge²

• Port signals

 $energy_{ports,modes} = \sum_{time} signals_{ports,modes}^2 * time step size$

 By using a cumulative sum one can see the evolution of the power deposition (does it all get dumped quickly, or in a more gradual way).

fractional loss down the beam pipe = $\frac{\text{port1 energy} + \text{port2 energy}}{\text{loss from beam}}$

Analysis details – Frequency domain

- Zero pad in time domain
- FFT time data

bunch spectra = $\frac{FFT(\text{charge distribution})}{\text{number of sample points}}$ FFT of scaled wake potential = $\frac{FFT(\text{Wake Potential * model charge})}{\text{number of sample points}}$ Wake Impedance = $-\Re\left(\frac{\text{FFT of scaled wake potential}}{\text{bunch spectra}}\right)$ bunch power = $\sum_{\text{frequency}} \left(|\text{bunch spectra}|^2 * \text{Wake Impedance}\right)$

• Zero the wake impedance when the power in the bunch is small. (combats numerical noise).

energy for 1 bunch = bunch power * simulation time

wake loss factor = $\frac{\text{energy for 1 bunch}}{\text{model charge}^2}$

• Using the ports

Total power spectrum =
$$\sum_{\text{port mode}} \left| FFT(\text{port signals}) \right|^2$$

Total power from all ports = $\sum_{\text{time}} |\text{Total power spectrum}|$

Machine parameters to bunch parameters

bunch charge = $\frac{\text{beam current}}{\frac{1}{\text{pulse gap}} * \frac{\text{fill pattern}}{936}}$ $\sigma = 3.87 + 2.41 \left(\frac{\text{beam current}}{\text{fill pattern}}\right)^{0.81} \sqrt{\frac{2.5}{\text{RF Volts}}}$

Pulse equations

Single pulse

pulse =
$$\frac{1}{\sqrt{2\pi\sigma}}e^{-\frac{\text{Wake Potential timescale}^2}{2\sigma^2}}$$
 model charge

Train
pulse =
$$\sum_{n=1}^{N} \frac{1}{\sqrt{2\pi\sigma}} e^{-\frac{(\text{Wake Potential timescale} + (gap * n))^2}{2\sigma^2}}$$
 model charge